Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/654,343	NAKATANI ET AL.
Examiner	Art Unit

Rick K. Chang

3729

SEARCHED					
Class	Subclass	Date	Examiner		
29	832,83584 1,739,740	2/3/2006	RC		
228	110.1				
156	48				
174	52.2-52.4				
310	312,340				
*	346,344				
	348,313R				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
<u> </u>					

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
reviewed parent case and references cited therein	2/3/2006	RC